

## 1. General description

Silicon Carbide MOSFET in a TO263-7L plastic package, designed for high frequency, high efficiency systems.



AEC - Q101 Qualified



## 2. Features and benefits

- Low on-resistance
- Fast switching speed
- 0V turn-off gate voltage for simple gate driver
- Easy to parallel
- 100% UIS Tested
- Controllable dV/dt for optimized EMI
- Reduced cooling requirements
- RoHS compliant

## 3. Applications

- Switch Mode Power Supplies
- UPS
- Solar string inverter and solar optimizer
- EV Charger
- Motor Drives

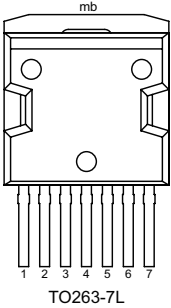
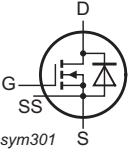
## 4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values			Unit
<b>Absolute maximum rating</b>							
$V_{DS}$	drain-source voltage	$25\text{ °C} \leq T_j \leq 175\text{ °C}$		1200			V
$I_D$	drain current	$V_{GS} = 18\text{ V}; T_{mb} = 25\text{ °C}$		70			A
$P_{tot}$	total power dissipation	$T_{mb} = 25\text{ °C}, T_j = 175\text{ °C}$		278			W
$T_j$	junction temperature			-55 to 175			°C
Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
<b>Static characteristics</b>							
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 15\text{ V}; I_D = 33\text{ A}; T_j = 25\text{ °C}$		-	40	-	mΩ
<b>Dynamic characteristics</b>							
$Q_{G(tot)}$	total gate charge	$I_D = 33\text{ A}; V_{DS} = 800\text{ V}; V_{GS} = -4\text{ V}/18\text{ V}; T_j = 25\text{ °C}$		-	115	-	nC
$Q_{GD}$	gate-drain charge			-	18	-	nC
<b>Source-drain diode</b>							
$Q_r$	recovered charge	$I_{SD} = 33\text{ A}; di/dt = 500\text{ A}/\mu\text{s}; V_{DS} = 400\text{ V}; T_j = 25\text{ °C}$		-	174	-	nC

## 5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	 <p>TO263-7L</p>	 <p>sym301</p>
2	SS	source sense		
3-7	S	source		
mb	D	mounting base; connected to drain		

## 6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WNSC2M40120B7-A	TO263-7L	WNSC2M40120B7-A6J	Reel	800	TO263P-7L	12-Jun-2023

## 7. Marking

Table 4. Marking codes

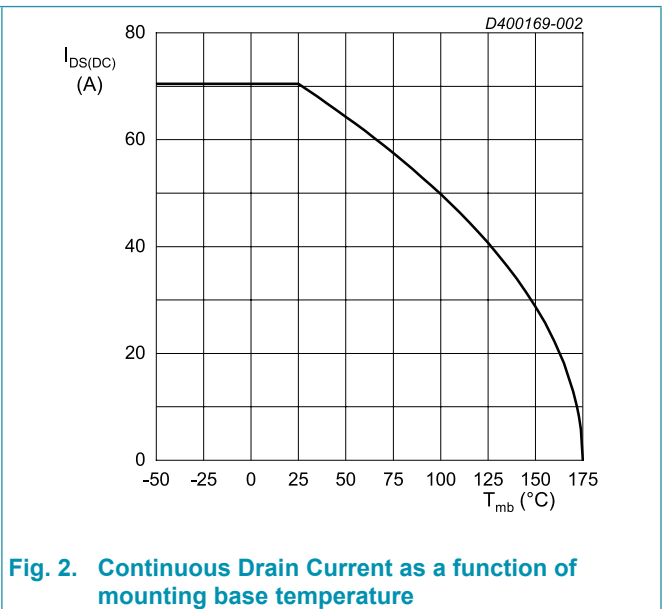
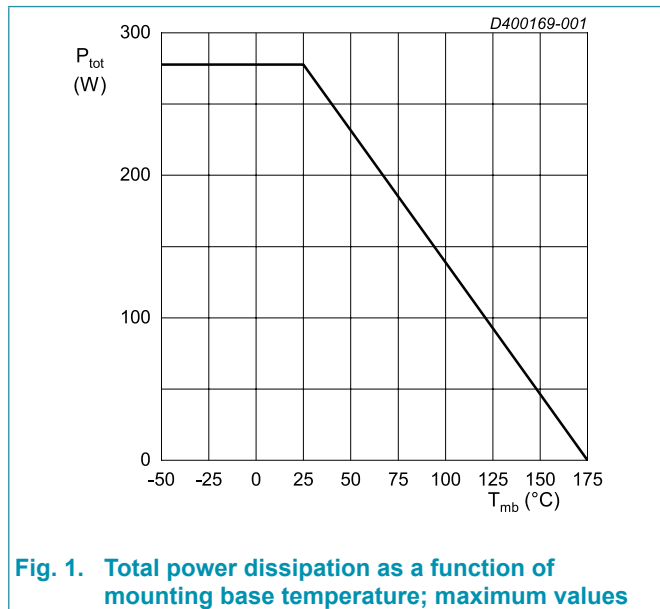
Type number	Marking codes
WNSC2M40120B7-A	WNSC2M 40120B7-A

## 8. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
$V_{DS}$	drain-source voltage	$25\text{ °C} \leq T_j \leq 175\text{ °C}$		1200	V
$V_{GS,max}$	gate-source voltage			-10 to 22	V
$V_{GS,op}$	gate-source voltage			-4 to 18	V
$P_{tot}$	total power dissipation	$T_{mb} = 25\text{ °C}, T_j = 175\text{ °C}$		278	W
$I_D$	drain current	$V_{GS} = 18\text{ V}; T_{mb} = 25\text{ °C}$		70	A
		$V_{GS} = 18\text{ V}; T_{mb} = 100\text{ °C}$		50	A
$I_{DM}$	peak drain current	pulse width $t_p$ limited by $T_{jmax}$	Fig.17	140	A
$I_S$	continuous diode current	$V_{GS} = -4\text{ V}; T_{mb} = 25\text{ °C}$		50	A
$I_{SM}$	pulse diode current	$V_{GS} = -4\text{ V}$ ; pulse width $t_p$ limited by $T_{jmax}$		140	A
$E_{as}$	single pulse drain-to-source avalanche	$I_{AS} = 24\text{ A}; L = 1\text{ mH}; V_{DD} = 100\text{ V}; T_j = 25\text{ °C}$		288	mJ
$T_{stg}$	storage temperature			-55 to 175	°C
$T_j$	junction temperature			-55 to 175	°C
$T_{sld(M)}$	peak soldering temperature			260	°C

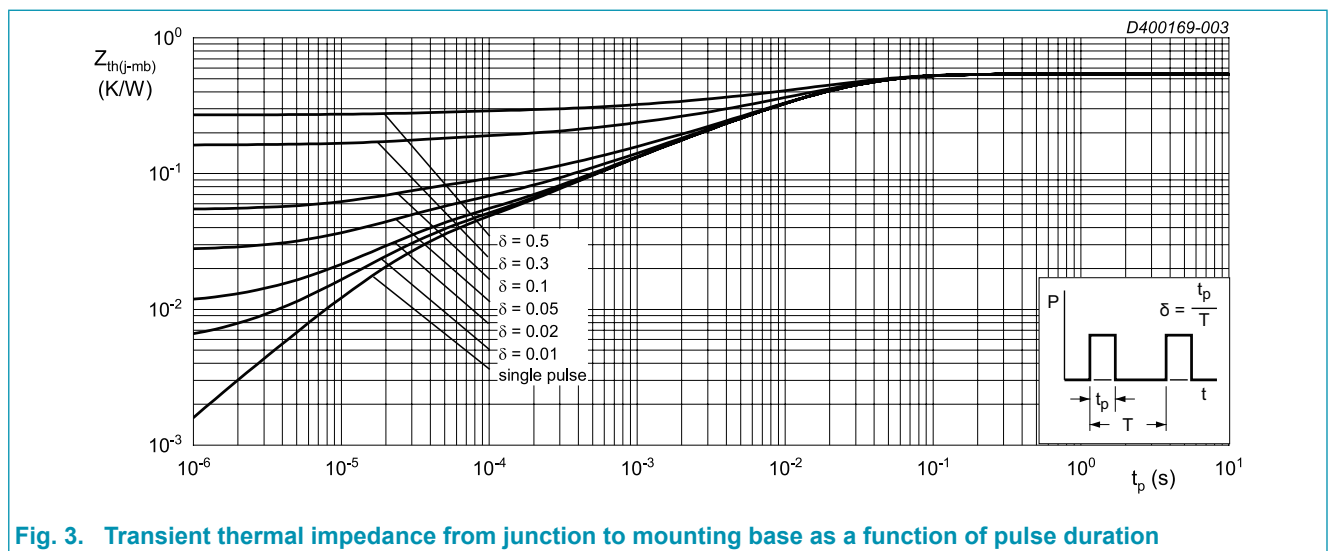


## 9. Thermal & Mechanical characteristics

**Table 6. Thermal & Mechanical characteristics**

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base			-	0.54	-	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air		-	40	-	K/W

Note: It is recommended that a metal washer is inserted between screw head and mounting tab.  
Do not use self-tapping screws.  
Device is ESD sensitive. Handling precautions are recommended.

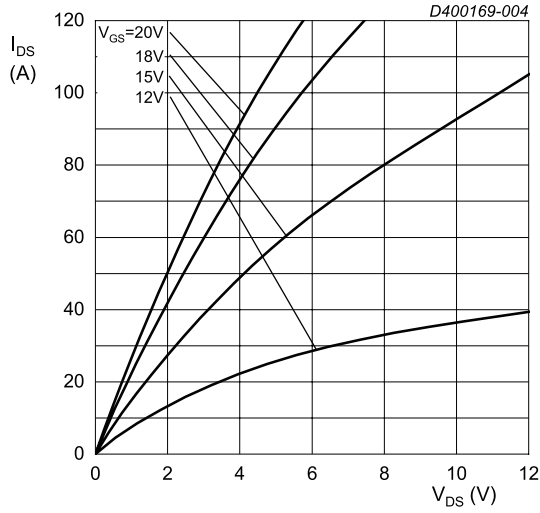


**Fig. 3. Transient thermal impedance from junction to mounting base as a function of pulse duration**

## 10. Characteristics

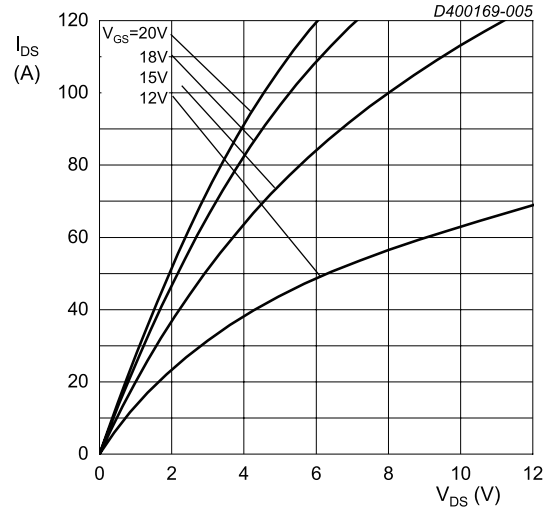
Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
<b>Static characteristics</b>							
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 100 \mu A$ ; $V_{GS} = 0 V$ ; $T_j = 25 \text{ }^\circ C$		1200	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 10 \text{ mA}$ ; $V_{DS} = 10 V$ ; $T_j = 25 \text{ }^\circ C$		1.9	2.6	3.5	V
		$I_D = 10 \text{ mA}$ ; $V_{DS} = 10 V$ ; $T_j = 175 \text{ }^\circ C$		-	1.9	-	V
$I_{DSS}$	drain leakage current	$V_{DS} = 1200 V$ ; $V_{GS} = 0 V$ ; $T_j = 25 \text{ }^\circ C$		-	0.2	100	$\mu A$
		$V_{DS} = 1200 V$ ; $V_{GS} = 0 V$ ; $T_j = 175 \text{ }^\circ C$		-	2	-	$\mu A$
$I_{GSS}$	gate leakage current	$V_{GS} = 24 V$ ; $V_{DS} = 0 V$ ; $T_j = 25 \text{ }^\circ C$		-	10	100	nA
		$V_{GS} = -12 V$ ; $V_{DS} = 0 V$ ; $T_j = 25 \text{ }^\circ C$		-	10	100	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = 15 V$ ; $I_D = 33 A$ ; $T_j = 25 \text{ }^\circ C$		-	40	-	m $\Omega$
		$V_{GS} = 18 V$ ; $I_D = 33 A$ ; $T_j = 25 \text{ }^\circ C$		-	33	45	m $\Omega$
		$V_{GS} = 18 V$ ; $I_D = 33 A$ ; $T_j = 175 \text{ }^\circ C$		-	56	-	m $\Omega$
$R_G$	gate resistance	$f = 1 \text{ MHz}$ ; $T_j = 25 \text{ }^\circ C$		-	1	-	$\Omega$
$g_{fs}$	transconductance	$V_{DS} = 20 V$ ; $I_D = 33 A$ ; $T_j = 25 \text{ }^\circ C$		-	20	-	S
<b>Dynamic characteristics</b>							
$Q_{G(tot)}$	total gate charge	$I_D = 33 A$ ; $V_{DS} = 800 V$ ; $V_{GS} = -4 V/18 V$ ; $T_j = 25 \text{ }^\circ C$		-	115	-	nC
$Q_{GS}$	gate-source charge			-	47	-	nC
$Q_{GD}$	gate-drain charge			-	18	-	nC
$C_{iss}$	input capacitance	$V_{DS} = 1000 V$ ; $V_{GS} = 0 V$ ; $f = 1 \text{ MHz}$ ; $T_j = 25 \text{ }^\circ C$		-	2450	-	pF
$C_{oss}$	output capacitance			-	108	-	pF
$C_{rss}$	reverse transfer capacitance			-	11	-	pF
$E_{oss}$	Coss stored energy			-	54	-	$\mu J$
$t_{d(on)}$	turn-on delay time	$V_{DS} = 800 V$ ; $V_{GS} = -4 V/18 V$ ; $R_{G(ext)} = 2.4 \Omega$ ; $I_D = 33 A$ ; $L = 100 \mu H$ ; $T_j = 25 \text{ }^\circ C$		-	23	-	ns
$t_r$	rise time			-	20	-	ns
$t_{d(off)}$	turn-off delay time			-	37	-	ns
$t_f$	fall time			-	28	-	ns
$E_{on}$	turn-on energy (Body Diode FWD)		Fig.20	-	208	-	$\mu J$
$E_{off}$	turn-off energy (Body Diode FWD)		Fig.20	-	85	-	$\mu J$
<b>Source-drain diode</b>							
$V_{SD}$	source-drain voltage	$V_{GS} = 0 V$ ; $I_{SD} = 16.5 A$ ; $T_j = 25 \text{ }^\circ C$		-	3.2	-	V
		$V_{GS} = -4 V$ ; $I_{SD} = 16.5 A$ ; $T_j = 25 \text{ }^\circ C$		-	4.8	-	V
		$V_{GS} = -4 V$ ; $I_{SD} = 16.5 A$ ; $T_j = 175 \text{ }^\circ C$		-	4.2	-	V
$t_{rr}$	reverse recovery time	$I_{SD} = 33 A$ ; $di/dt = 500 A/\mu s$ ; $V_{DS} = 400 V$ ; $T_j = 25 \text{ }^\circ C$		-	52	-	ns
$Q_r$	recovered charge			-	174	-	nC
$I_{rrm}$	reverse recovery current			-	6.8	-	A



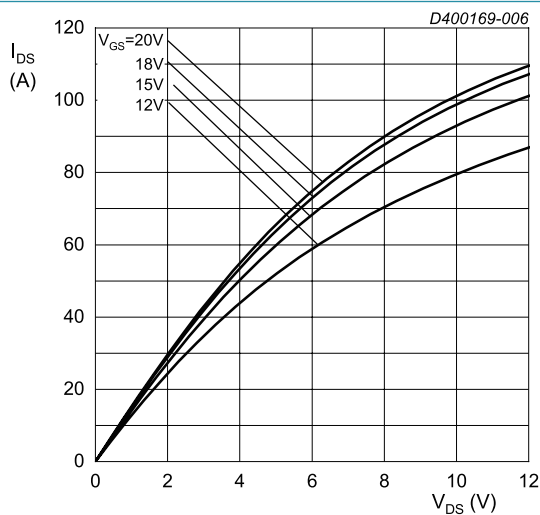
$T_j = -55\text{ }^\circ\text{C}; t_p < 200\text{ }\mu\text{s}$

Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values



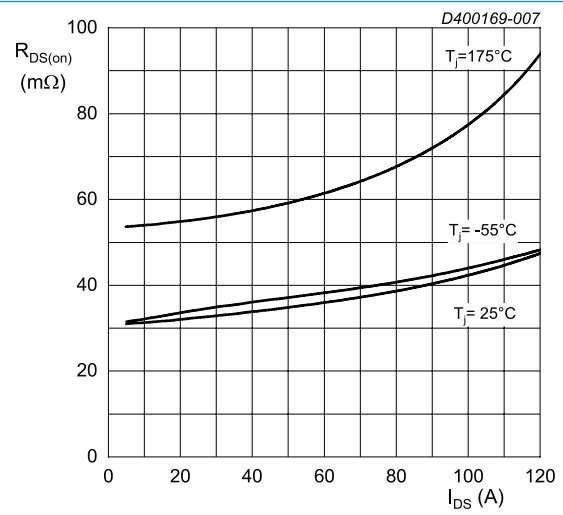
$T_j = 25\text{ }^\circ\text{C}; t_p < 200\text{ }\mu\text{s}$

Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values



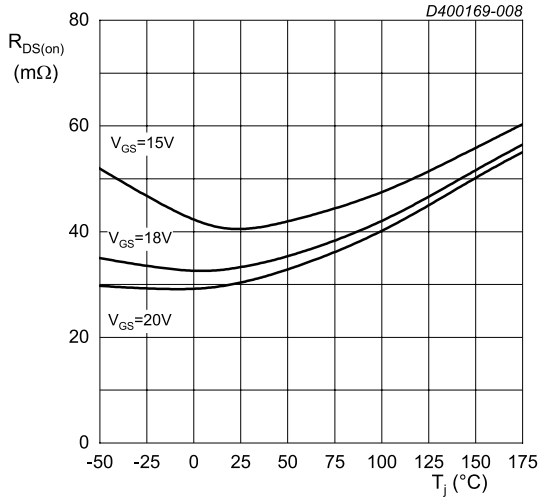
$T_j = 175\text{ }^\circ\text{C}; t_p < 200\text{ }\mu\text{s}$

Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values

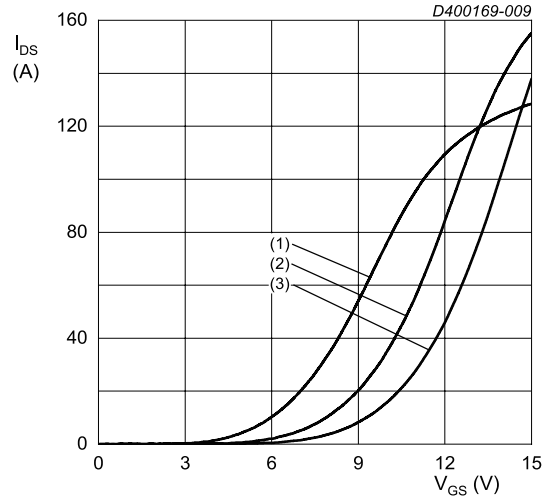


$V_{GS} = 18\text{ V}; t_p < 200\text{ }\mu\text{s}$

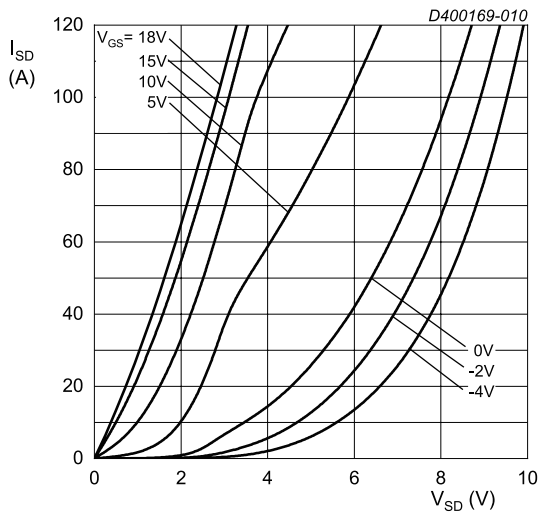
Fig. 7. Drain-source on-state resistance as a function of drain current; typical values



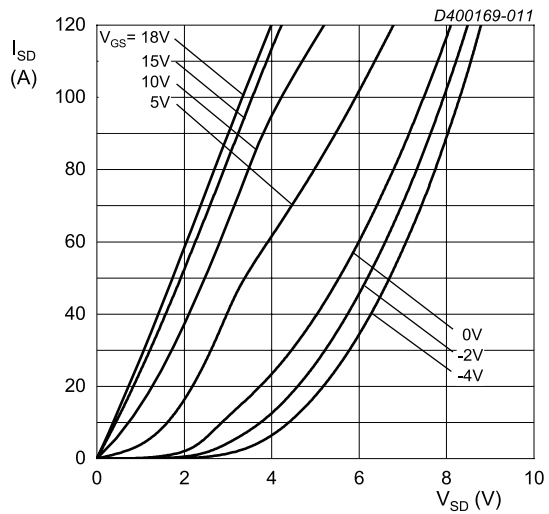
$I_{DS} = 33 A; t_p < 200 \mu s$   
**Fig. 8. Drain-source on-state resistance as a function of junction temperature**



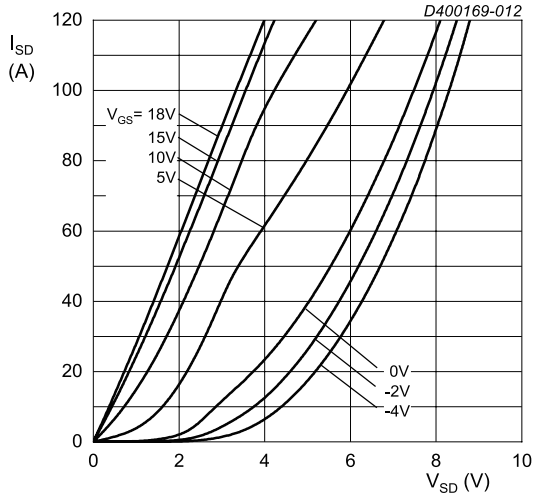
$V_{DS} = 20 V; t_p < 200 \mu s$   
 (1)  $T_j = 175^{\circ}C$   
 (2)  $T_j = 25^{\circ}C$   
 (3)  $T_j = -55^{\circ}C$   
**Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values**



$T_j = -55^{\circ}C; t_p < 200 \mu s$   
**Fig. 10. Body diode forward characteristics; typical values**

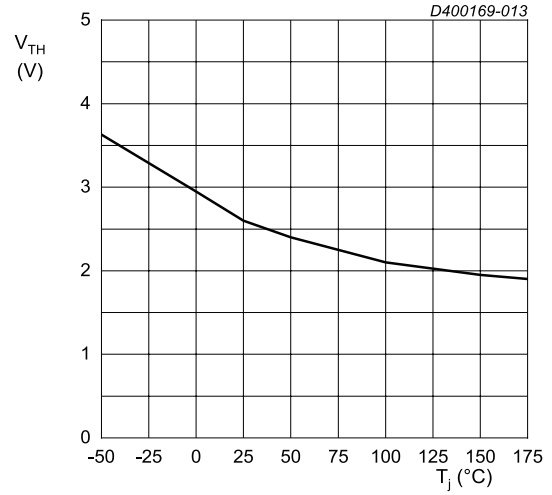


$T_j = 25^{\circ}C; t_p < 200 \mu s$   
**Fig. 11. Body diode forward characteristics; typical values**



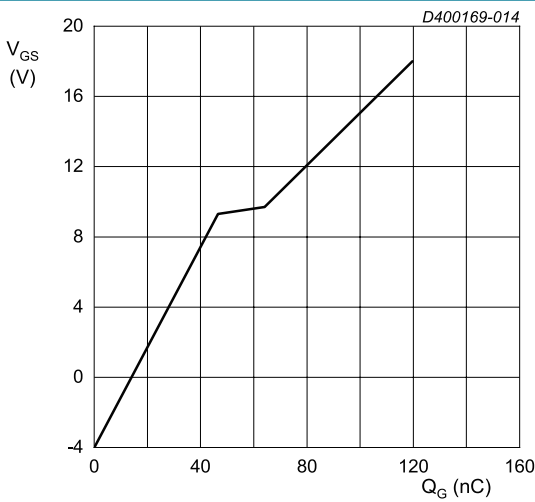
$T_j = 175\text{ }^\circ\text{C}$ ;  $t_p < 200\text{ }\mu\text{s}$

Fig. 12. Body diode forward characteristics; typical values



$V_{DS} = 10\text{ V}$ ;  $I_{DS} = 10\text{ mA}$

Fig. 13. Threshold voltage as a function of junction temperature



$I_{DS} = 33\text{ A}$ ;  $I_{GS} = 0.1\text{ mA}$ ;  $V_{DS} = 800\text{ V}$ ;  $T_j = 25\text{ }^\circ\text{C}$

Fig. 14. Gate-source voltage as a function of gate charge; typical values

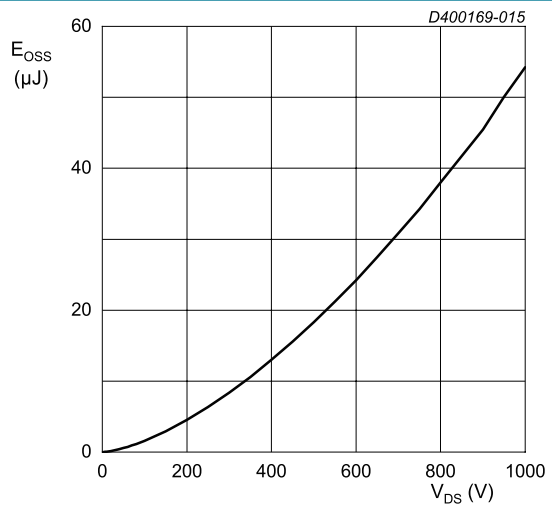
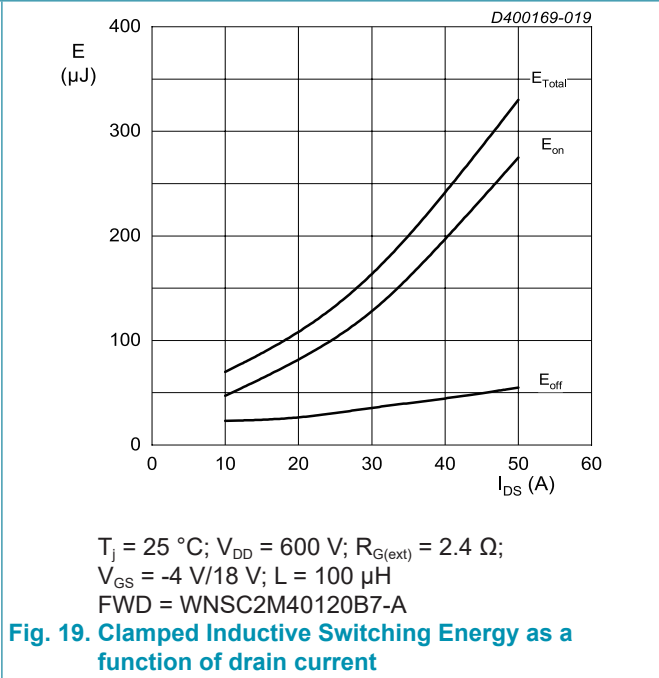
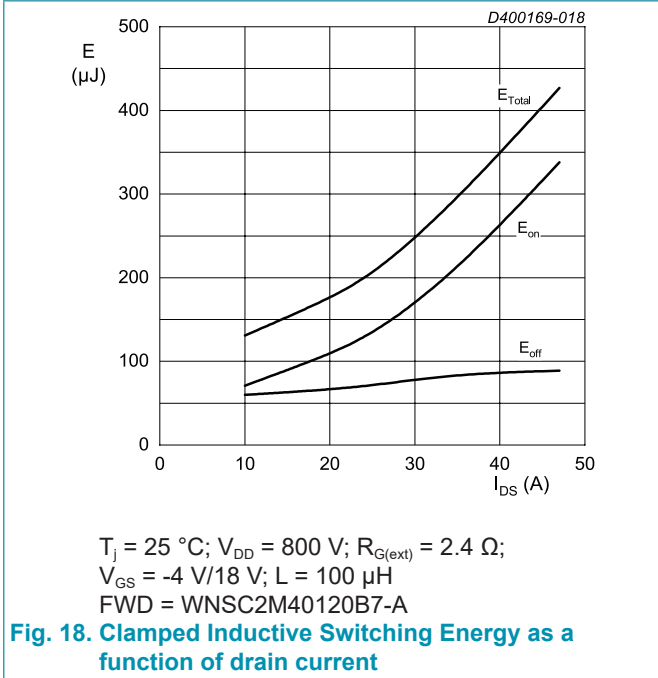
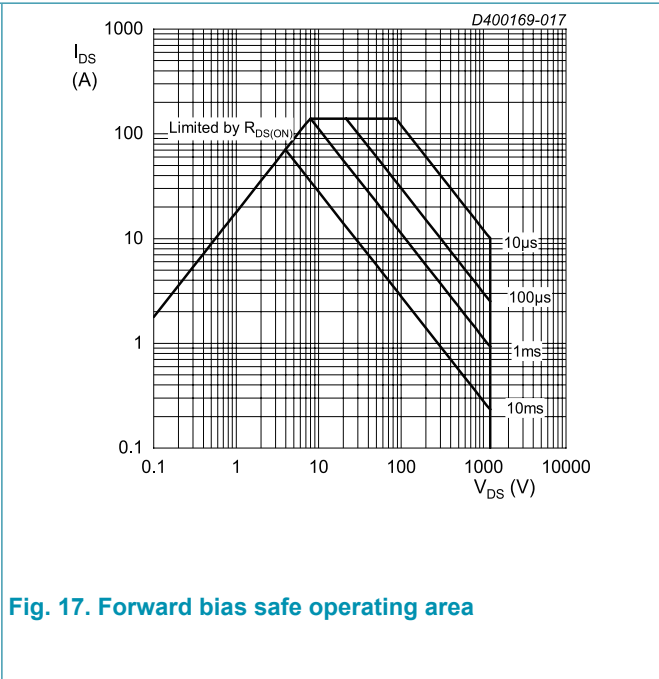
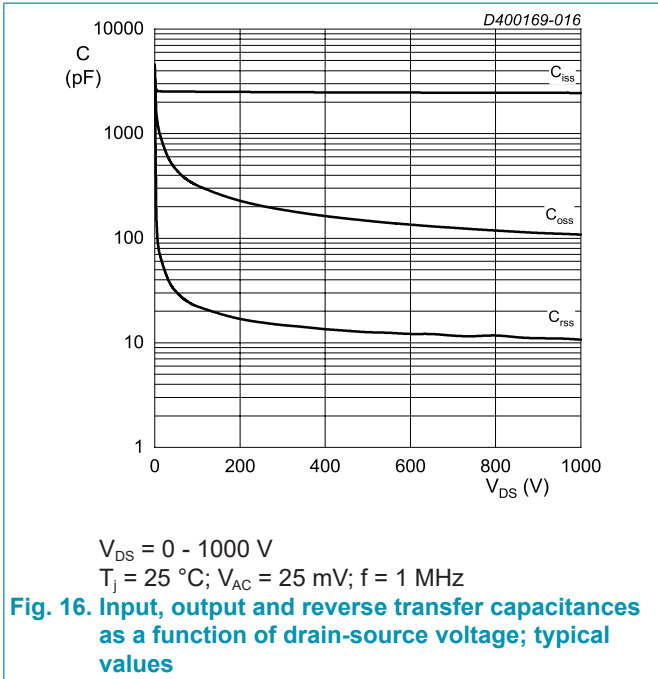
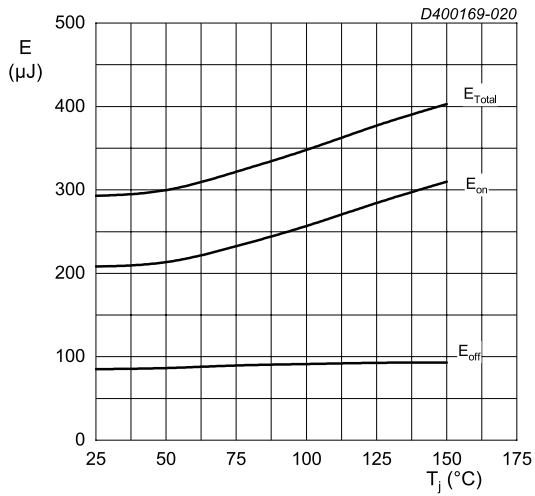


Fig. 15. Output capacitor stored energy as a function of drain-source voltage

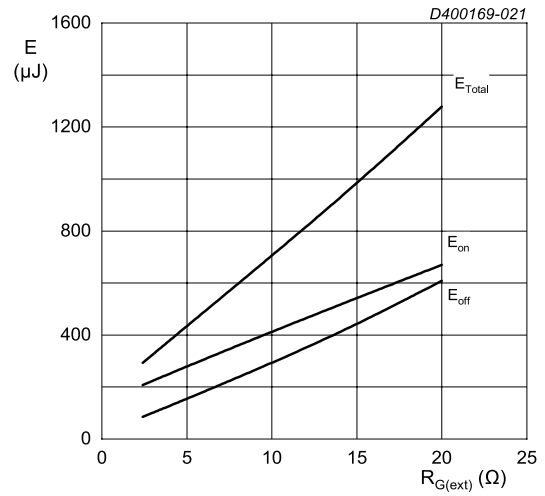






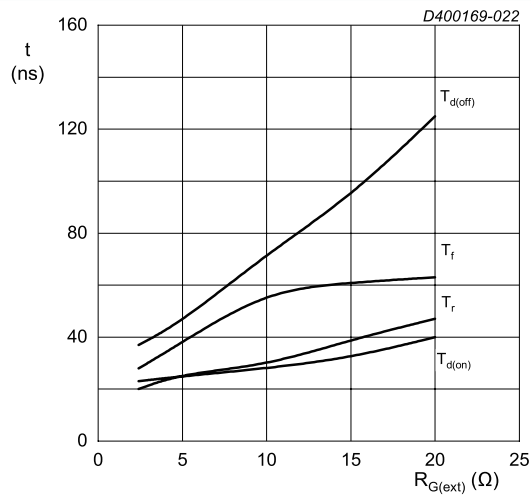
I<sub>DS</sub> = 33 A; V<sub>DD</sub> = 800 V; R<sub>G(ext)</sub> = 2.4 Ω;  
 V<sub>GS</sub> = -4 V/18 V; L = 100 μH  
 FWD = WNSC2M40120B7-A

Fig. 20. Clamped Inductive Switching Energy as a function of junction temperature



T<sub>j</sub> = 25 °C; V<sub>DD</sub> = 800 V; I<sub>DS</sub> = 33 A; V<sub>GS</sub> = -4 V/18 V  
 FWD = WNSC2M40120B7-A; L = 100 μH

Fig. 21. Clamped Inductive Switching Energy as a function of external gate resistance



T<sub>j</sub> = 25 °C; V<sub>DD</sub> = 800 V; I<sub>DS</sub> = 33 A; V<sub>GS</sub> = -4 V/18 V  
 FWD = WNSC2M40120B7-A; L = 100 μH

Fig. 22. Switching time as a function of external gate resistance

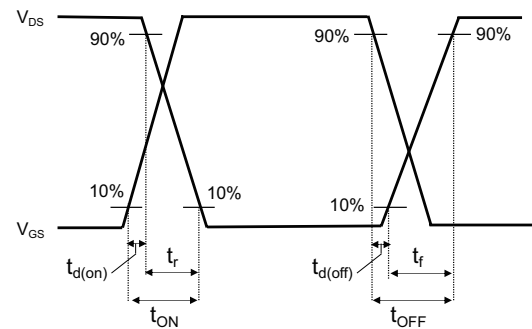
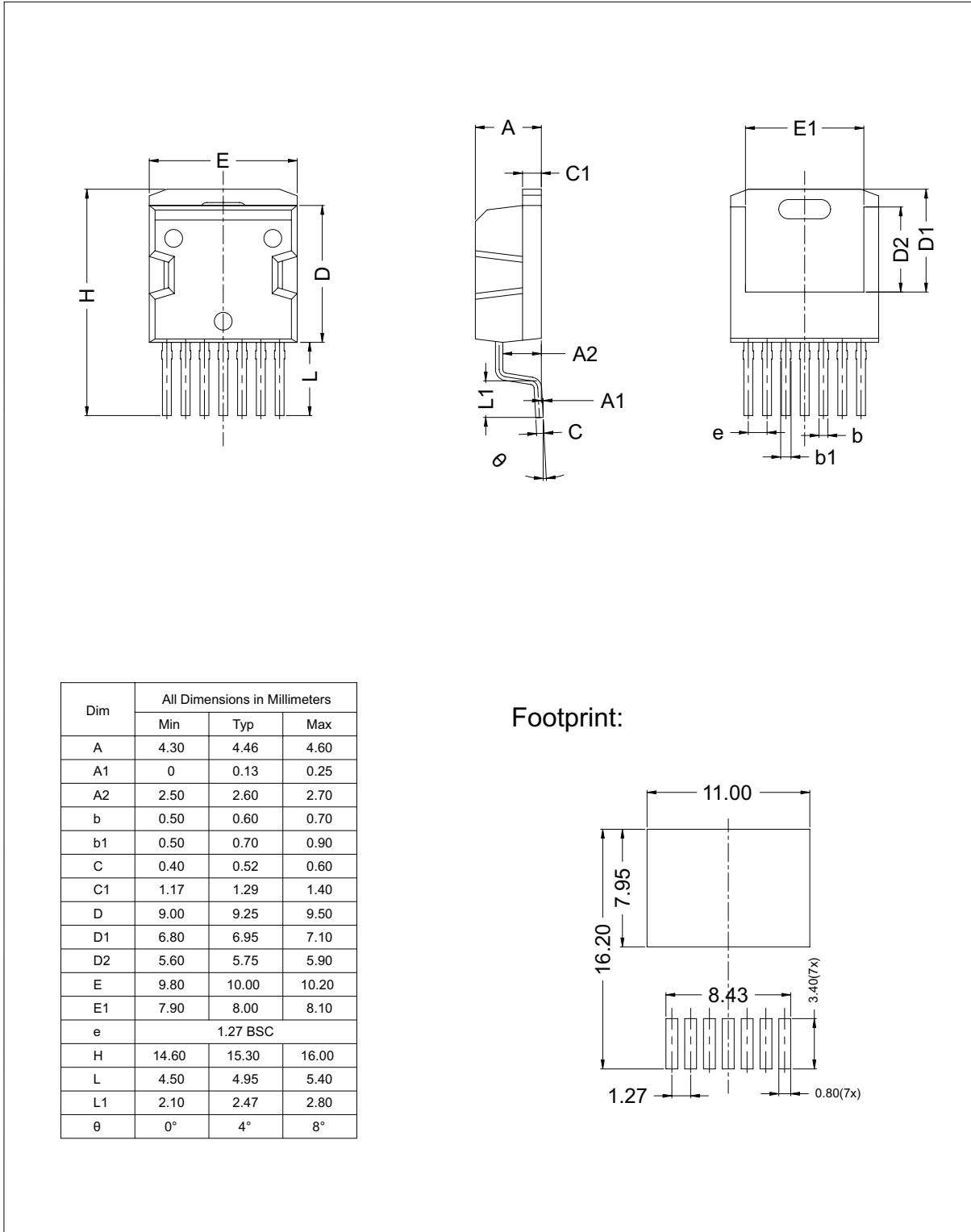


Fig. 23. Switching time definition

### 11. Package outline



## 12. Legal information

### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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### 13. Contents

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- 1. General description..... 1
- 2. Features and benefits ..... 1
- 3. Applications ..... 1
- 4. Quick reference data..... 1
- 5. Pinning information..... 2
- 6. Ordering information..... 2
- 7. Marking..... 2
- 8. Limiting values ..... 3
- 9. Thermal & Mechanical characteristics ..... 4
- 10. Characteristics..... 5
- 11. Package outline ..... 11
- 12. Legal information ..... 12
- 13. Contents ..... 14

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For sales office addresses, please send an email to: [salesaddresses@ween-semi.com](mailto:salesaddresses@ween-semi.com)  
Date of release: 26 September 2024

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